








Subst. Form PTO-1449 APPLICANT'S(S') INFORMATION DISCLOSURE STATEMENT		Atty. Docket No.: D/A1090 XER 2 0430		Serial No.: Unknown	
Applicant(s): Schweid		Filing Date: Herewith		Group: Unknown	

1000 U.S. PTO
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 101/07/02

U.S. PATENT DOCUMENTS							
Initial*	Document No.	Date	Name	Class	Subcl.	Filing Date	
	AA	4,723,297	Postl				
	AB	5,001,766	Baird				
	AC	5,187,753	Bloomberg et al.				
	AD	5,355,420	Bloomberg et al.				
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
Document No.	Date	Country	Class	Subcl.	Translation?		
AL							
AM							
AN							
AO							
AP							

OTHER ART		
	AR	"Accurate Skew Estimation and the Top-Down Analysis of Document Images." Baird, Henry S. December 12, 1986.
	AS	"Measuring Document Image Skew and Orientation." Bloomberg et al. <i>SPIE Symposium in Document Recognition II</i> , 1995.
	AT	

Examiner: 	Date Considered: 1/6/05
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if in conformance and not considered. Include copy of this form with next communication to applicant.